

PLG Radial Lead Type, Higher Capacitance



PLG

Higher Capacitance
PLF

- Higher Capacitance, Low ESR, High ripple current.
- Load life of 2000 hours at 105°C.
- Radial lead type :
Lead free flow soldering condition correspondence
- Compliant to the RoHS directive (2011/65/EU,(EU)2015/863).

■ Specifications

Item	Performance Characteristics									
Category Temperature Range	-55 to +105°C									
Rated Voltage Range	2.5 to 16V									
Rated Capacitance Range	330 to 3900µF									
Capacitance Tolerance	±20% at 120Hz, 20°C									
Tangent of loss angle (tan δ)	Less than or equal to the specified value at 120Hz, 20°C									
ESR (※ 1)	Less than or equal to the specified value at 100kHz, 20°C									
Leakage Current (※ 2)	Less than or equal to the specified value. After 2 minutes' application of rated voltage at 20°C									
Temperature Characteristics (Max.Impedance Ratio)	Z+105°C / Z+20°C ≤ 1.25 (100kHz) Z-55°C / Z+20°C ≤ 1.25									
Endurance	The specifications listed at right shall be met when the capacitors are restored to 20°C after the rated voltage is applied for 2000 hours at 105°C.	<table border="1"> <tr><td>Capacitance change</td><td>Within ± 20% of the initial capacitance value (※ 3)</td></tr> <tr><td>tan δ</td><td>150% or less than the initial specified value</td></tr> <tr><td>ESR (※ 1)</td><td>150% or less than the initial specified value</td></tr> <tr><td>Leakage current (※ 2)</td><td>Less than or equal to the initial specified value</td></tr> </table>	Capacitance change	Within ± 20% of the initial capacitance value (※ 3)	tan δ	150% or less than the initial specified value	ESR (※ 1)	150% or less than the initial specified value	Leakage current (※ 2)	Less than or equal to the initial specified value
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Damp Heat (Steady State)	The specifications listed at right shall be met when the capacitors are restored to 20°C after the rated voltage is applied for 1000 hours at 60°C, 90% RH.	<table border="1"> <tr><td>Capacitance change</td><td>Within ± 20% of the initial capacitance value (※ 3)</td></tr> <tr><td>tan δ</td><td>150% or less than the initial specified value</td></tr> <tr><td>ESR (※ 1)</td><td>150% or less than the initial specified value</td></tr> <tr><td>Leakage current (※ 2)</td><td>Less than or equal to the initial specified value</td></tr> </table>	Capacitance change	Within ± 20% of the initial capacitance value (※ 3)	tan δ	150% or less than the initial specified value	ESR (※ 1)	150% or less than the initial specified value	Leakage current (※ 2)	Less than or equal to the initial specified value
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tan δ	150% or less than the initial specified value									
ESR (※ 1)	150% or less than the initial specified value									
Leakage current (※ 2)	Less than or equal to the initial specified value									
Resistance to Soldering Heat	After soldering the capacitor under the soldering conditions prescribed here as preheat at 150 to 200°C for 60 to 180 seconds and peak temperature at 265°C for 10 seconds or less, the capacitor shall meet the specifications listed at right, provided that its temperature profile is measured at both of terminal ends facing the soldering side.	<table border="1"> <tr><td>Capacitance change</td><td>Within ± 10% of the initial capacitance value (※ 3)</td></tr> <tr><td>tan δ</td><td>130% or less than the initial specified value</td></tr> <tr><td>ESR (※ 1)</td><td>130% or less than the initial specified value</td></tr> <tr><td>Leakage current (※ 2)</td><td>Less than or equal to the initial specified value</td></tr> </table>	Capacitance change	Within ± 10% of the initial capacitance value (※ 3)	tan δ	130% or less than the initial specified value	ESR (※ 1)	130% or less than the initial specified value	Leakage current (※ 2)	Less than or equal to the initial specified value
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tan δ	130% or less than the initial specified value									
ESR (※ 1)	130% or less than the initial specified value									
Leakage current (※ 2)	Less than or equal to the initial specified value									
Marking	Navy blue print on the case top									

- ※ 1 ESR should be measured at both of the terminal ends closest to the capacitor body.
- ※ 2 Conditioning : If any doubt arises, measure the leakage current after the voltage treatment of applying DC rated voltage continuously to the capacitor for 120 minutes at 105°C.
- ※ 3 Initial value : The value before test of examination of resistance to soldering.

■ Dimensions



Size	(mm)		
	φ8 × 9L	φ8 × 12L	φ10 × 13L
φD	8.0	8.0	10.0
L	8.5	11.5	12.5
P	3.5	3.5	5.0
φd	0.6	0.6	0.6

Voltage						
V	2.5	4	6.3	10	16	
Code	e	g	j	A	C	

Type numbering system (Example : 4V 1200µF)



● Frequency coefficient of rated ripple current

Frequency	120Hz	1kHz	10kHz	100kHz or more
Coefficient	0.05	0.30	0.70	1.00

Please refer to page 20 about the end seal configuration.

● Dimension table in next page.

PLG

■ Dimensions

Rated Voltage (V) Code	Surge Voltage (V)	Rated Capacitance (μF)	Case Size φD × L (mm)	tan δ	Leakage Current (μA)	ESR (mΩ) (at 100kHz 20°C)	Rated Ripple (mA _{rms}) (105°C/100kHz)	Part Number
2.5 (0E)	2.8	1800	8 × 9	0.08	900	9	6000	PLG0E182MCO1
		2200	8 × 12	0.08	1100	8	6700	PLG0E222MDO1
		2700	10 × 13	0.08	1350	8	5560	PLG0E272MDO1
		3900	10 × 13	0.08	1950	8	7000	PLG0E392MDO1
4 (0G)	4.6	1200	8 × 9	0.08	960	9	5900	PLG0G122MCO1
		1800	8 × 12	0.08	1440	9	6500	PLG0G182MDO1
		2700	10 × 13	0.08	2160	8	6900	PLG0G272MDO1
6.3 (0J)	7.2	820	8 × 9	0.08	1033	9	5700	PLG0J821MCO1
		1200	8 × 12	0.08	1512	9	6100	PLG0J122MDO1
		1500	10 × 13	0.08	1890	9	6300	PLG0J152MDO1
		1800	10 × 13	0.08	2268	8	6600	PLG0J182MDO1
10 (1A)	11.5	560	8 × 9	0.08	1120	11	5100	PLG1A561MCO1
		820	8 × 12	0.08	1640	10	5800	PLG1A821MDO1
		1200	10 × 13	0.08	2400	9	6200	PLG1A122MDO1
16 (1C)	18.4	330	8 × 9	0.08	1056	13	4700	PLG1C331MCO1
		470	8 × 12	0.08	1504	11	5400	PLG1C471MDO1
		820	10 × 13	0.08	2624	11	5600	PLG1C821MDO1

Rated ripple current (mA_{rms}) at 105°C 100kHz

- Please refer to page 20, 21, 22 about the formed or taped product spec.
- Please refer to page 3 for the minimum order quantity.

Данный компонент на территории Российской Федерации

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Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

moschip.ru_6

moschip.ru_9